

Silver indium diphosphate, AgInP_2O_7

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Key indicators: single-crystal X-ray study; $T = 296$ K, $P = 0.0$ kPa; mean $\sigma(\text{P}=\text{O}) = 0.002$ Å; R factor = 0.021; wR factor = 0.048; data-to-parameter ratio = 36.9.

Polycrystalline material of the title compound, AgInP_2O_7 , was synthesized by traditional high-temperature solid-state methods and single crystals were grown from the melt of a mixture of AgInP_2O_7 and B_2O_3 as flux in a platinum crucible. The structure consists of InO_6 octahedra, which are corner-shared to PO_4 tetrahedra into a three-dimensional network with hexagonal channels running parallel to the c axis. The silver cation, located in the channel, is bonded to seven O atoms of the $[\text{InP}_2\text{O}_7]$ framework with Ag–O distances ranging from 2.370 (2) to 3.015 (2) Å. The P_2O_7 diphosphate anion is characterized by a P–O–P angle of 137.27 (9) and a nearly eclipsed conformation. AgInP_2O_7 is isotypic with the $M^{\text{I}}\text{FeP}_2\text{O}_7$ ($M^{\text{I}} = \text{Na, K, Rb, Cs and Ag}$) diphosphate family.

Related literature

For properties of $M^{\text{I}}\text{FeP}_2\text{O}_7$ ($M^{\text{I}} = \text{Na, K, Rb, Cs and Ag}$) diphosphates, see: Terebilenko *et al.* (2010); Hizhnyi *et al.* (2008); Whangbo *et al.* (2004); Vitins *et al.* (2000). For isotypic structures, see: Belkouch *et al.* (1995); Gabelica-Robert *et al.* (1982); Moya-Pizarro *et al.* (1984); Mercader *et al.* (1990).

Experimental

Crystal data

AgInP_2O_7
 $M_r = 396.63$
Monoclinic, $P2_1/c$

$a = 7.4867$ (3) Å
 $b = 8.2620$ (3) Å
 $c = 9.8383$ (5) Å

$\beta = 112.038$ (2)°
 $V = 564.09$ (4) Å³
 $Z = 4$
Mo $K\alpha$ radiation

$\mu = 8.11$ mm⁻¹
 $T = 296$ K
 $0.08 \times 0.06 \times 0.05$ mm

Data collection

Bruker X8 APEXII CCD area-detector diffractometer
Absorption correction: multi-scan (*SADABS*; Sheldrick, 1999)
 $T_{\min} = 0.563$, $T_{\max} = 0.667$

21692 measured reflections
3730 independent reflections
3245 reflections with $I > 2\sigma(I)$
 $R_{\text{int}} = 0.035$

Refinement

$R[F^2 > 2\sigma(F^2)] = 0.021$
 $wR(F^2) = 0.048$
 $S = 1.03$
3730 reflections

101 parameters
 $\Delta\rho_{\max} = 1.62$ e Å⁻³
 $\Delta\rho_{\min} = -2.04$ e Å⁻³

Data collection: *APEX2* (Bruker, 2005); cell refinement: *SAINT* (Bruker, 2005); data reduction: *SAINT*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL97* (Sheldrick, 2008); molecular graphics: *ORTEP-3 for Windows* (Farrugia, 1997); software used to prepare material for publication: *WinGX* (Farrugia, 1999).

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Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: BR2154).

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supplementary materials

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Silver indium diphosphate, AgInP₂O₇

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Comment

The diphosphates $A^I M^{III} P_2 O_7$ ($A^I = Li, Na, K, Rb, Cs$ and Ag ; $M^{III} = Al, Ga, Cr, Fe, In, Y$) are extensively studied for their electrical and optical properties and for its perspective application as magnetic materials (Terebilenko *et al.* (2010); Hizhnyi *et al.* (2008); Whangbo *et al.* (2004); Vitins *et al.* (2000)). The crystal structures of most of these compounds are known except a few cases in which the crystal growth is difficult. In this context, the present paper reports on the determination of AgInP₂O₇ crystal structure from X-ray diffraction single-crystal data.

The structure of this phosphate is characterized by a three-dimensional network built up from indium octahedra linked to diphosphate groups by a corner-sharing. Each InO₆ octahedra is surrounded by six PO₄ tetrahedra belonging to five different P₂O₇ groups (see Fig.1 and Fig.2). As a result of these blocks, assemblage three-dimensional-framework is formed with hexagonal channels, where silver cations reside. Although, the coordination sphere of Ag⁺ cations is composed of seven O²⁻ anions in an irregular geometry, located at Ag–O distances between 2.370 (2) and 3.015 (2) Å (see Fig.2). Furthermore, the diphosphate group contains two distorted PO₄ tetrahedra sharing one corner and display a nearly eclipsed conformation. The P–O bond-lengths range between 1.492 (2) Å for terminal P1–O1 and 1.606 (2) Å for the bridging P2–O7 bond. Therefore, a P1–O7–P2 angle of 137.27 (9) ° is wider than 133.6 (3)° and 132.9 (3) ° reported for both AgFeP₂O₇ and NaFeP₂O₇ respectively (Belkouch *et al.* (1995); Gabelica-Robert *et al.* (1982); Moya-Pizarro *et al.* (1984); Mercader *et al.* (1990)).

Silver indium diphosphate (pyrophosphate) is isostructural to A^IFeP₂O₇ (A^I = Na, K, Rb, Cs and Ag) diphosphates family and is categorized as a dichromate type.

Experimental

AgInP₂O₇ in the form of single crystals was prepared by stoichiometric reaction of AgNO₃, (NH₄)₂HPO₄ and In₂O₃ in B₂O₃ flux. The mixture was heated at 773 K under ambient atmosphere for 6 h and 973 K for 2 h with intermediate grindings to ensure complete reaction. Subsequent melting at 1323 K followed by slow cooling to room temperature at a rate of 12°K h⁻¹ resulted in colourless crystals of the title compound.

Refinement

The highest and deepest hole residual peak in the final difference Fourier map are located at 0.49 Å and 0.58 Å, respectively from Ag1 atom. The not significant bonds and angles were removed from the CIF file.

supplementary materials

Figures

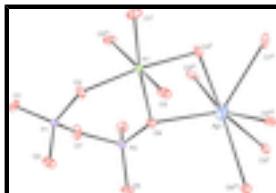


Fig. 1. Partial plot of AgInP_2O_7 crystal structure showing polyhedra linkage. Displacement ellipsoids are drawn at the 50% probability level. Symmetry codes: (i) $-x + 1, y - 1/2, -z + 1/2$; (ii) $-x, y - 1/2, -z + 1/2$; (iii) $-x + 1, -y + 1, -z + 1$; (iv) $x, -y + 3/2, z - 1/2$; (v) $x - 1, y, z$; (vi) $x - 1, -y + 3/2, z - 1/2$; (vii) $-x, -y + 1, -z + 1$.

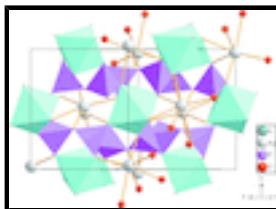


Fig. 2. Perspective view along [101] of the AgInP_2O_7 framework structure showing tunnel where silver cations are located.

Silver indium diphosphate

Crystal data

AgInP_2O_7

$F(000) = 728$

$M_r = 396.63$

$D_x = 4.670 \text{ Mg m}^{-3}$

Monoclinic, $P2_1/c$

Cell parameters from 317 reflections

Hall symbol: $-P\ 2ybc$

$\theta = 2.5\text{--}30.2^\circ$

$a = 7.4867 (3) \text{ \AA}$

$\mu = 8.11 \text{ mm}^{-1}$

$b = 8.2620 (3) \text{ \AA}$

$T = 296 \text{ K}$

$c = 9.8383 (5) \text{ \AA}$

Block, colourless

$\beta = 112.038 (2)^\circ$

$0.08 \times 0.06 \times 0.05 \text{ mm}$

$V = 564.09 (4) \text{ \AA}^3$

$Z = 4$

Data collection

Bruker X8 APEXII CCD area-detector diffractometer

3730 independent reflections

Radiation source: fine-focus sealed tube graphite

3245 reflections with $I > 2\sigma(I)$

ω and φ scans

$R_{\text{int}} = 0.035$

Absorption correction: multi-scan (*SADABS*; Sheldrick, 1999)

$\theta_{\max} = 41.0^\circ, \theta_{\min} = 2.9^\circ$

$T_{\min} = 0.563, T_{\max} = 0.667$

$h = -13 \rightarrow 13$

21692 measured reflections

$k = -15 \rightarrow 15$

$l = -18 \rightarrow 18$

Refinement

Refinement on F^2

Primary atom site location: structure-invariant direct methods

Least-squares matrix: full

Secondary atom site location: difference Fourier map

$R[F^2 > 2\sigma(F^2)] = 0.021$	$w = 1/[\sigma^2(F_o^2) + (0.017P)^2 + 0.9979P]$ where $P = (F_o^2 + 2F_c^2)/3$
$wR(F^2) = 0.048$	$(\Delta/\sigma)_{\max} = 0.001$
$S = 1.03$	$\Delta\rho_{\max} = 1.62 \text{ e \AA}^{-3}$
3730 reflections	$\Delta\rho_{\min} = -2.04 \text{ e \AA}^{-3}$
101 parameters	Extinction correction: <i>SHELXL97</i> (Sheldrick, 2008), $F_c^* = k F_c [1 + 0.001 x F_c^2 \lambda^3 / \sin(2\theta)]^{-1/4}$
0 restraints	Extinction coefficient: 0.0171 (4)

Special details

Geometry. All s.u.'s (except the s.u. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell s.u.'s are taken into account individually in the estimation of s.u.'s in distances, angles and torsion angles; correlations between s.u.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell s.u.'s is used for estimating s.u.'s involving l.s. planes.

Refinement. Refinement of F^2 against ALL reflections. The weighted R -factor wR and goodness of fit S are based on F^2 , conventional R -factors R are based on F , with F set to zero for negative F^2 . The threshold expression of $F^2 > \sigma(F^2)$ is used only for calculating R -factors(gt) etc. and is not relevant to the choice of reflections for refinement. R -factors based on F^2 are statistically about twice as large as those based on F , and R -factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (\AA^2)

	x	y	z	$U_{\text{iso}}^*/U_{\text{eq}}$
In1	0.242354 (15)	0.495357 (12)	0.247622 (11)	0.00618 (3)
Ag1	-0.20911 (3)	0.52697 (2)	0.30478 (2)	0.02442 (4)
P1	0.57689 (6)	0.74758 (5)	0.46083 (4)	0.00600 (6)
P2	0.17589 (6)	0.78735 (5)	0.45174 (4)	0.00656 (6)
O1	0.6810 (2)	0.86792 (17)	0.40464 (15)	0.0141 (2)
O2	0.6836 (2)	0.71622 (16)	0.62241 (14)	0.0136 (2)
O3	0.52473 (17)	0.59259 (15)	0.36935 (14)	0.01027 (19)
O4	0.04427 (18)	0.91166 (17)	0.35059 (15)	0.0123 (2)
O5	0.1917 (2)	0.79561 (16)	0.60976 (14)	0.0126 (2)
O6	0.13231 (18)	0.61348 (15)	0.39564 (14)	0.01054 (19)
O7	0.37868 (18)	0.83601 (16)	0.44239 (16)	0.0128 (2)

Atomic displacement parameters (\AA^2)

	U^{11}	U^{22}	U^{33}	U^{12}	U^{13}	U^{23}
In1	0.00656 (4)	0.00614 (4)	0.00593 (4)	-0.00024 (3)	0.00244 (3)	-0.00045 (3)
Ag1	0.01913 (7)	0.02720 (8)	0.03341 (9)	-0.00235 (6)	0.01725 (7)	-0.01071 (7)
P1	0.00574 (14)	0.00643 (14)	0.00582 (14)	-0.00025 (11)	0.00217 (11)	0.00044 (11)
P2	0.00588 (14)	0.00706 (14)	0.00644 (14)	0.00073 (11)	0.00195 (11)	-0.00090 (12)
O1	0.0185 (6)	0.0141 (5)	0.0133 (5)	-0.0053 (4)	0.0104 (5)	0.0012 (4)
O2	0.0195 (6)	0.0098 (5)	0.0070 (4)	-0.0006 (4)	-0.0001 (4)	0.0018 (4)
O3	0.0072 (4)	0.0099 (5)	0.0130 (5)	-0.0012 (3)	0.0030 (4)	-0.0040 (4)
O4	0.0084 (5)	0.0135 (5)	0.0135 (5)	0.0034 (4)	0.0023 (4)	0.0041 (4)

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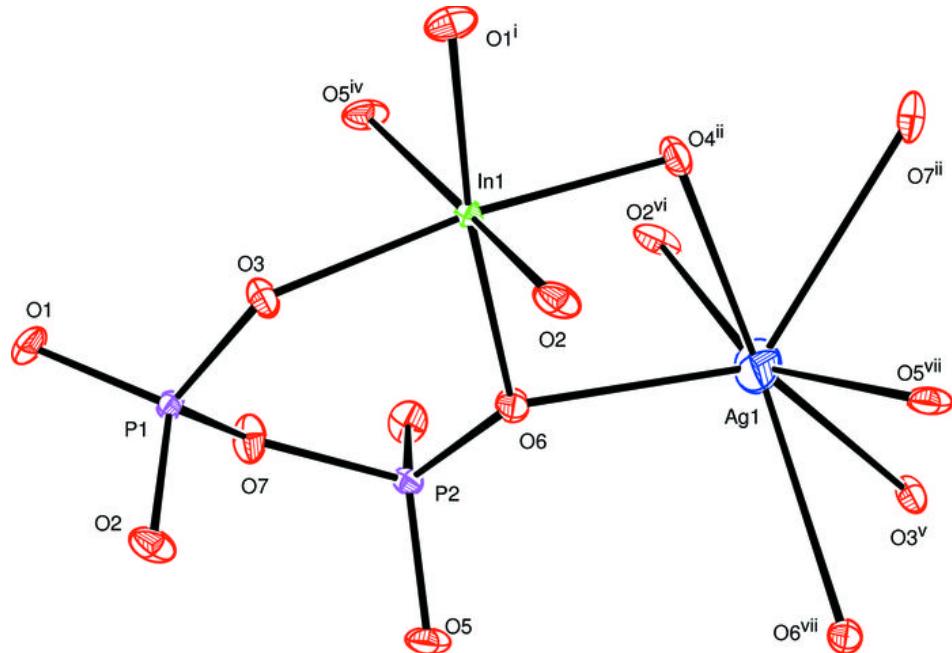
O5	0.0211 (6)	0.0099 (5)	0.0072 (4)	-0.0009 (4)	0.0058 (4)	-0.0023 (4)
O6	0.0116 (5)	0.0097 (5)	0.0123 (5)	-0.0019 (4)	0.0067 (4)	-0.0039 (4)
O7	0.0078 (5)	0.0100 (5)	0.0217 (6)	0.0010 (4)	0.0069 (4)	-0.0020 (4)

Geometric parameters (\AA , $^\circ$)

In1—O1 ⁱ	2.0799 (13)	Ag1—O5 ^{vii}	2.7829 (14)
In1—O4 ⁱⁱ	2.1120 (12)	Ag1—O6 ^{vii}	3.0153 (14)
In1—O2 ⁱⁱⁱ	2.1133 (13)	P1—O1	1.4919 (13)
In1—O5 ^{iv}	2.1401 (13)	P1—O2	1.5097 (13)
In1—O3	2.1562 (12)	P1—O3	1.5292 (13)
In1—O6	2.1569 (12)	P1—O7	1.6021 (13)
Ag1—O3 ^v	2.3703 (12)	P2—O4	1.5101 (13)
Ag1—O6	2.4757 (13)	P2—O5	1.5158 (13)
Ag1—O4 ⁱⁱ	2.4865 (14)	P2—O6	1.5295 (13)
Ag1—O2 ^{vi}	2.6991 (14)	P2—O7	1.6062 (13)
Ag1—O7 ⁱⁱ	2.7744 (15)		
O1 ⁱ —In1—O4 ⁱⁱ	90.70 (6)	O3 ^v —Ag1—O5 ^{vii}	94.99 (4)
O1 ⁱ —In1—O2 ⁱⁱⁱ	86.35 (6)	O6—Ag1—O5 ^{vii}	104.03 (4)
O4 ⁱⁱ —In1—O2 ⁱⁱⁱ	89.82 (6)	O4 ⁱⁱ —Ag1—O5 ^{vii}	80.85 (4)
O1 ⁱ —In1—O5 ^{iv}	89.04 (5)	O2 ^{vi} —Ag1—O5 ^{vii}	157.25 (4)
O4 ⁱⁱ —In1—O5 ^{iv}	93.79 (5)	O7 ⁱⁱ —Ag1—O5 ^{vii}	71.00 (4)
O2 ⁱⁱⁱ —In1—O5 ^{iv}	174.18 (6)	O3 ^v —Ag1—O6 ^{vii}	72.37 (4)
O1 ⁱ —In1—O3	96.36 (5)	O6—Ag1—O6 ^{vii}	88.04 (4)
O4 ⁱⁱ —In1—O3	172.86 (5)	O4 ⁱⁱ —Ag1—O6 ^{vii}	119.79 (4)
O2 ⁱⁱⁱ —In1—O3	89.55 (5)	O2 ^{vi} —Ag1—O6 ^{vii}	148.46 (4)
O5 ^{iv} —In1—O3	87.43 (5)	O7 ⁱⁱ —Ag1—O6 ^{vii}	119.64 (4)
O1 ⁱ —In1—O6	173.56 (5)	O5 ^{vii} —Ag1—O6 ^{vii}	50.65 (4)
O4 ⁱⁱ —In1—O6	82.94 (5)	O1—P1—O2	111.17 (8)
O2 ⁱⁱⁱ —In1—O6	92.62 (5)	O1—P1—O3	113.17 (8)
O5 ^{iv} —In1—O6	92.35 (5)	O2—P1—O3	113.16 (8)
O3—In1—O6	89.98 (5)	O1—P1—O7	104.17 (8)
O3 ^v —Ag1—O6	134.04 (4)	O2—P1—O7	107.40 (8)
O3 ^v —Ag1—O4 ⁱⁱ	155.99 (4)	O3—P1—O7	107.10 (7)
O6—Ag1—O4 ⁱⁱ	69.47 (4)	O4—P2—O5	115.20 (8)
O3 ^v —Ag1—O2 ^{vi}	85.86 (5)	O4—P2—O6	113.76 (8)
O6—Ag1—O2 ^{vi}	91.29 (4)	O5—P2—O6	109.65 (8)
O4 ⁱⁱ —Ag1—O2 ^{vi}	89.15 (5)	O4—P2—O7	100.90 (8)
O3 ^v —Ag1—O7 ⁱⁱ	102.17 (4)	O5—P2—O7	109.63 (8)
O6—Ag1—O7 ⁱⁱ	123.47 (4)	O6—P2—O7	107.01 (7)
O4 ⁱⁱ —Ag1—O7 ⁱⁱ	54.04 (4)	P1—O7—P2	137.27 (9)
O2 ^{vi} —Ag1—O7 ⁱⁱ	86.57 (4)		

Symmetry codes: (i) $-x+1, y-1/2, -z+1/2$; (ii) $-x, y-1/2, -z+1/2$; (iii) $-x+1, -y+1, -z+1$; (iv) $x, -y+3/2, z-1/2$; (v) $x-1, y, z$; (vi) $x-1, -y+3/2, z-1/2$; (vii) $-x, -y+1, -z+1$.

Fig. 1



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Fig. 2

